

MOSFET

OptiMOS™ 5 Power-Transistor, 80 V

Features

- N-channel, normal level
- Very low on-resistance R_{DS(on)}
- Superior thermal resistance
- · Optimized design for double side cooling
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

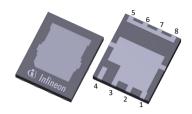
Product validation

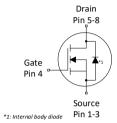
Fully qualified according to JEDEC for Industrial Applications

Table 1 Key Performance Parameters

Parameter	Value	Unit
$V_{ m DS}$	80	V
R _{DS(on),max}	1.57	mΩ
I_{D}	323	А
Q _{oss}	123	nC
Q_{G}	106	nC

PG-WHSON-8









Type/Ordering Code	Package	Marking	Related Links
IQD016N08NM5SC	PG-WHSON-8	GA	-

Public

OptiMOS™ 5 Power-Transistor, 80 V IQD016N08NM5SC



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OptiMOS™ 5 Power-Transistor, 80 V IQD016N08NM5SC



1 Maximum ratings

at T_A =25 °C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition	
raiailletei	Syllibot	Min.	Тур.	Max.	Ollic	Note/ Test Condition	
Continuous drain current ¹⁾	I_{D}	-	-	323 229 188 31	Α	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =6 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 °C/W ²⁾	
Pulsed drain current ³⁾	I _{D,pulse}	-	-	1292	А	<i>T</i> _C =25 °C	
Avalanche energy, single pulse ⁴⁾	E _{AS}	-	-	802	mJ	$I_{\rm D}$ =50 A, $R_{\rm GS}$ =25 Ω	
Gate source voltage	V_{GS}	-20	-	20	V	-	
Power dissipation	P_{tot}	-	-	333 3.0	w	$T_{\rm C}$ =25 °C $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 °C/W ²⁾	
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-55	-	175	°C	-	

¹⁾ Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

2 Thermal characteristics

Table 3 Thermal characteristics

Darameter	Symbol	Values			Unit	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Мах.	Offic	Note/ Test Condition
Thermal resistance, junction - case, bottom	R_{thJC}	-	-	0.45	°C/W	-
Thermal resistance, junction - case, top	R_{thJC}	-	-	0.56	°C/W	-
Thermal resistance, junction - ambient, 6 cm ² cooling area ⁵⁾	$R_{ m thJA}$	-	-	50	°C/W	-

⁵⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for source connection. PCB is vertical in still air.

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for source connection. PCB is vertical in still air.

³⁾ See Diagram 3 for more detailed information

⁴⁾ See Diagram 13 for more detailed information

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3 Electrical characteristics

at T_i =25 °C, unless otherwise specified

Table 4 Static characteristics

Parameter	Symbol	,	Values			Nata/Tast Canditian	
rarameter	Syllibot	Min.	Тур.	Мах.	Unit	Note/ Test Condition	
Drain-source breakdown voltage	V _{(BR)DSS}	80	-	-	V	V _{GS} =0 V, I _D =1 mA	
Gate threshold voltage	$V_{\rm GS(th)}$	2.2	3.0	3.8	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 159 \mu{\rm A}$	
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μΑ	$V_{\rm DS}$ =80 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C $V_{\rm DS}$ =80 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =125 °C	
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =20 V, V _{DS} =0 V	
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	-	1.4 1.9	1.57 2.32	mΩ	$V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A $V_{\rm GS}$ =6 V, $I_{\rm D}$ =50 A	
Gate resistance	R_{G}	-	0.35	-	Ω	-	
Transconductance	g_{fs}	-	140	-	S	$ V_{\rm DS} \ge 2 I_{\rm D} R_{\rm DS(on)max}, I_{\rm D}=50 \text{ A}$	

Table 5 Dynamic characteristics

Darameter	Symbol	Values			Unit	Note/ Test Condition	
Parameter	Symbol	Min.	Тур. Мах.		Unit	note/ rest condition	
Input capacitance ⁶⁾	C _{iss}	-	7100	9200	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz	
Output capacitance ⁶⁾	Coss	-	1200	1600	pF	$V_{\rm GS}$ =0 V, $V_{\rm DS}$ =40 V, f =1 MHz	
Reverse transfer capacitance ⁶⁾	C _{rss}	-	56	98	pF	$V_{\rm GS}$ =0 V, $V_{\rm DS}$ =40 V, f =1 MHz	
Turn-on delay time	$t_{\sf d(on)}$	-	15	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1. 6 Ω	
Rise time	t _r	-	7	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1. 6 Ω	
Turn-off delay time	$t_{\sf d(off)}$	-	29	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1. 6 Ω	
Fall time	t _f	_	10	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1. 6 Ω	

⁶⁾ Defined by design. Not subject to production test.

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Table 6 Gate charge characteristics 7)

Parameter	Cumbal	Values			Unit	Note / Test Condition	
raiailletei	Symbol	Min.	Тур.	Мах.	Oilit	Note/ Test Condition	
Gate to source charge	Q_{gs}	-	31	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge at threshold	$Q_{\mathrm{g(th)}}$	-	21	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V	
Gate to drain charge ⁸⁾	$Q_{ m gd}$	-	25	38	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V	
Switching charge	Q_{sw}	-	35	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge total ⁸⁾	Q_{g}	-	106	133	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V	
Gate plateau voltage	$V_{ m plateau}$	-	4.4	-	V	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge total, sync. FET	$Q_{g(sync)}$	-	90	-	nC	$V_{\rm DS}$ =0.1 V, $V_{\rm GS}$ =0 to 10 V	
Output charge ⁸⁾	$Q_{\rm oss}$	-	123	164	nC	$V_{\rm DS}$ =40 V, $V_{\rm GS}$ =0 V	

⁷⁾ See "Gate charge waveforms" for parameter definition

Table 7 Reverse diode

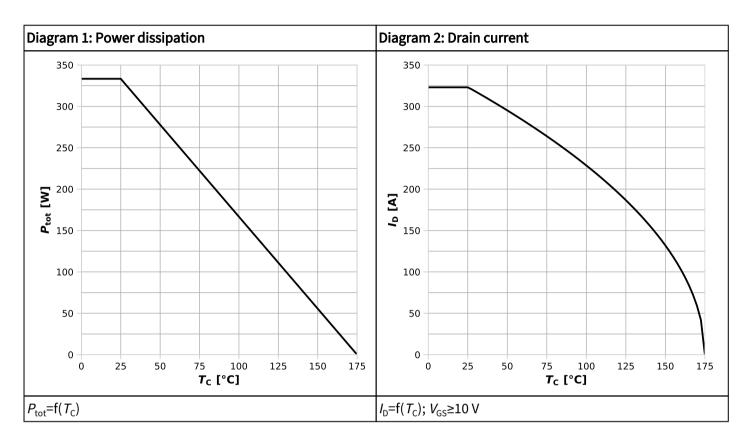
Parameter	Symbol	Values			Unit	Note / Test Condition	
raiailletei	Symbol	Min.	Тур.	Max.	Oilit	Note/ Test Condition	
Diode continuous forward current	I_{S}	-	-	256	А	<i>T</i> _c =25 °C	
Diode pulse current	I _{S,pulse}	-	-	1292	А	<i>T</i> _C =25 °C	
Diode forward voltage	$V_{\rm SD}$	-	0.82	1.0	V	$V_{\rm GS}$ =0 V, $I_{\rm F}$ =50 A, $T_{\rm j}$ =25 °C	
Reverse recovery time ⁹⁾	t _{rr}	-	48	96	ns	$V_{\rm R}$ =40 V, $I_{\rm F}$ =25 A, d $i_{\rm F}$ /d t =100 A/ μ s	
Reverse recovery charge ⁹⁾	$Q_{\rm rr}$	-	71	142	nC	$V_{\rm R}$ =40 V, $I_{\rm F}$ =25 A, d $i_{\rm F}$ /d t =100 A/ μ s	
Reverse recovery time ⁹⁾	t _{rr}	-	29	58	ns	$V_{\rm R}$ =40 V, $I_{\rm F}$ =50 A, d $i_{\rm F}$ /d t =1000 A/ μ s	
Reverse recovery charge ⁹⁾	$Q_{\rm rr}$	-	331	662	nC	$V_{\rm R}$ =40 V, $I_{\rm F}$ =50 A, d $i_{\rm F}$ /d t =1000 A/ μ s	

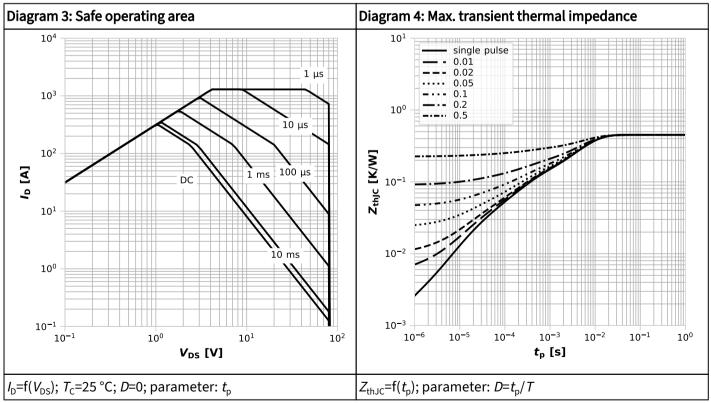
 $^{^{9)}}$ Defined by design. Not subject to production test.

⁸⁾ Defined by design. Not subject to production test.

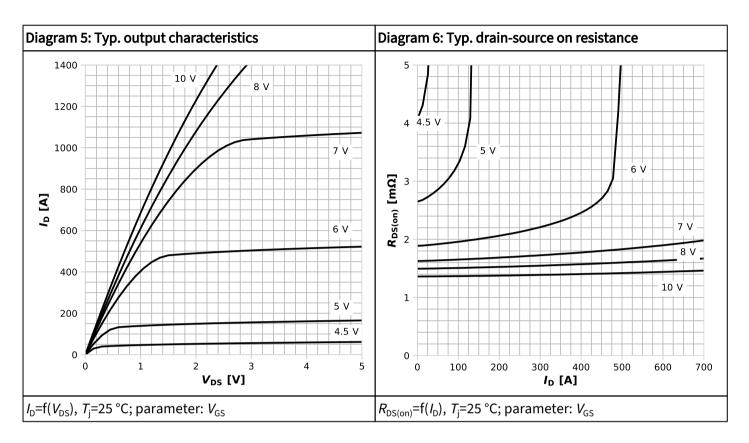


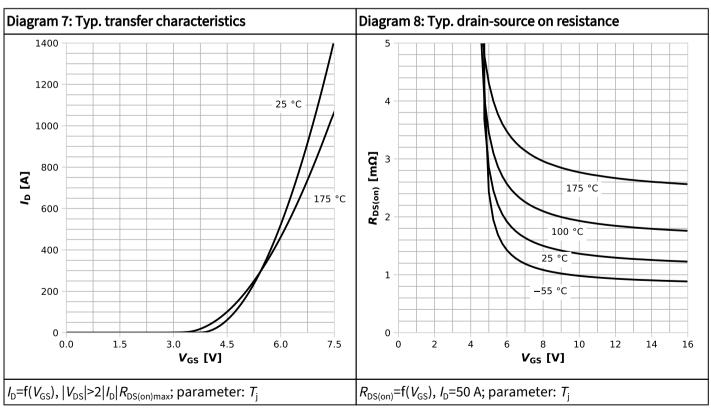
4 Electrical characteristics diagrams



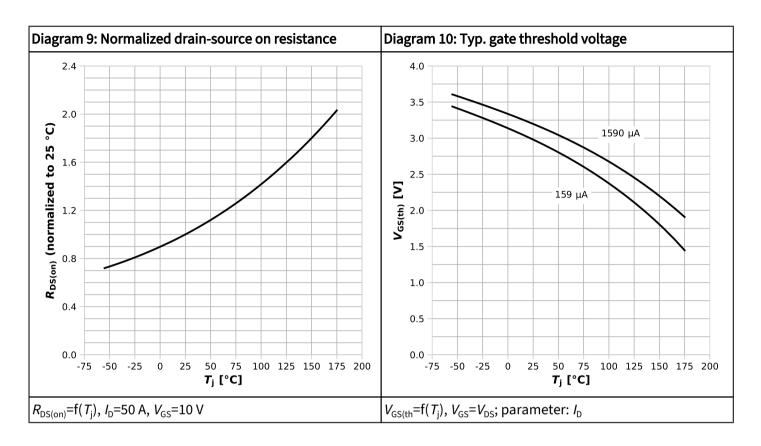


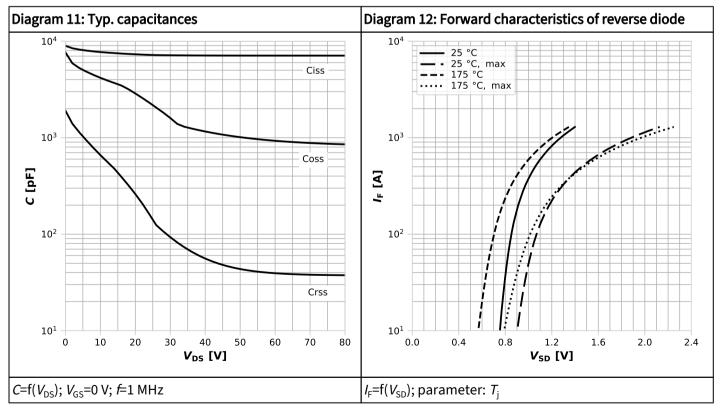




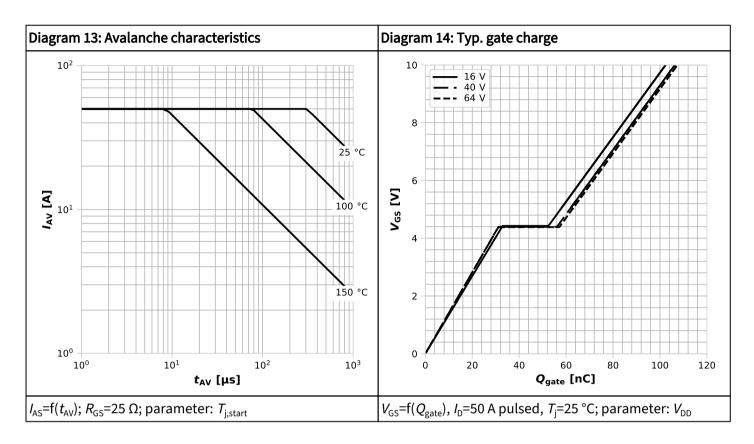


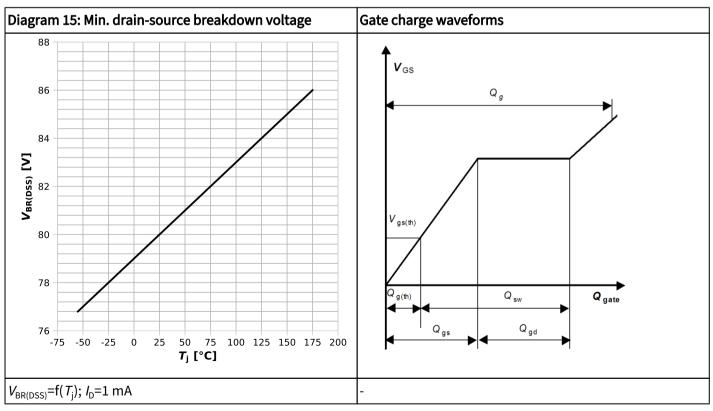






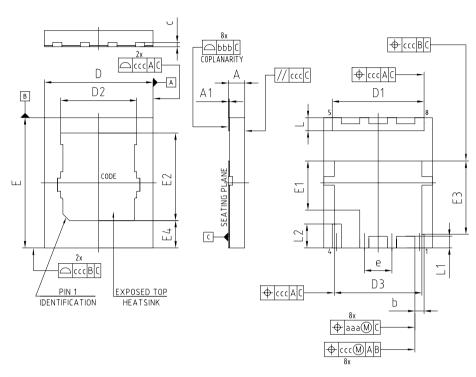








5 Package Outlines



PACKAGE - GROUP NUMBER:	PG-WHS	ON-8-U02			
DIMENSIONS	MILLIM	ETERS	DIMENSIONS	MILLIN	METERS
DIMENSIONS	MIN.	MAX.		MIN.	MAX.
Α	0.55	0.75	е	1	.27
A1	0.00	0.05	L	0.50	0.70
b	0.32	0.52	L1	0.44	0.64
С	0.10	0.30	L2	1.00	1.20
D	5.00		aaa	0.05	
D1	4.13	4.33	bbb	0	.08
D2	3.40	3.60	ccc	0	.10
D3	3.93	4.13			
E	6.	00	1		
E1	2.16	2.36]		
E2	3.93	4.13]		
E3	3.28	3.48]		
E4	1.16	1.36			

NOTE: DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

Figure 1 Outline PG-WHSON-8, dimensions in mm



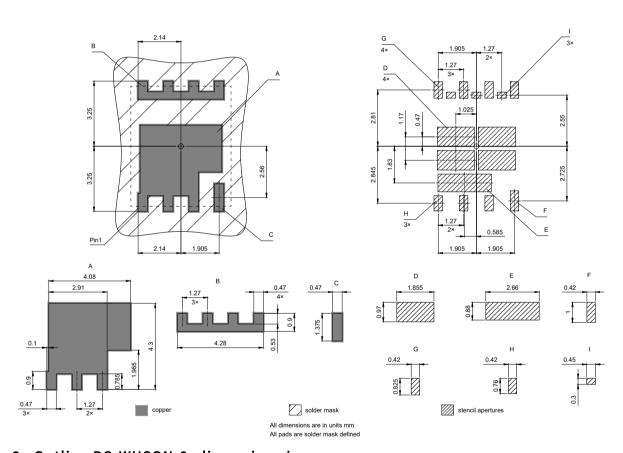


Figure 2 Outline PG-WHSON-8, dimensions in mm

OptiMOS™ 5 Power-Transistor, 80 V IQD016N08NM5SC



Revision History

IQD016N08NM5SC

Revision 2024-06-14, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2024-06-14	Release of final

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